

Search Notes

Application/Control No.

09/229,849

Examiner

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Applicant(s)/Patent under
Reexamination

SERRANO, MARTIN

Art Unit

2162

SEARCHED

Class	Subclass	Date	Examiner
707	1-10	6/23/2005	JBF
707	100-104.1	6/23/2005	JBF
707	200-206	6/23/2005	JBF
709	217	6/23/2005	JBF
709	218	6/23/2005	JBF
709	219	6/23/2005	JBF
717	115	6/23/2005	JBF
717	119	6/23/2005	JBF
717	149	6/23/2005	JBF

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
707	3	6/23/2005	JBF
707	6	6/23/2005	JBF
709 717	217 115	6/23/2005	JBF

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
WEST (US PG PUB, US PT, EPO, JPO, DERWENT AND IBM TDB)	6/23/2005	JBF
707/CCLS AND 709/CCLS AND 717/CCLS	6/23/2005	JBF
NPL - IEEE	6/23/2005	JBF
NPL - ACM	6/23/2005	JBF
STIC SEARCH - DIALOG	6/23/2005	JBF
CONSULTED TQAS 101 HELP PANEL	6/22/2005	JBF
CONSULTED KINDRED AND RONES C	6/23/2005	JBF